



August 2001  
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## 74LVT32373 • 74LVTH32373 Low Voltage 32-Bit Transparent Latch with 3-STATE Outputs (Preliminary)

### General Description

The LVT32373 and LVTH32373 contain thirty-two non-inverting latches with 3-STATE outputs and are intended for bus oriented applications. The device is byte controlled. The flip-flops appear transparent to the data when the Latch Enable (LE) is HIGH. When LE is LOW, the data that meets the setup time is latched. Data appears on the bus when the Output Enable ( $\overline{OE}$ ) is LOW. When  $\overline{OE}$  is HIGH, the outputs are in a high impedance state.

The LVTH32373 data inputs include bushold, eliminating the need for external pull-up resistors to hold unused inputs.

These latches are designed for low-voltage (3.3V)  $V_{CC}$  applications, but with the capability to provide a TTL interface to a 5V environment. The LVT32373 and LVTH32373 are fabricated with an advanced BiCMOS technology to achieve high speed operation similar to 5V ABT while maintaining a low power dissipation.

### Features

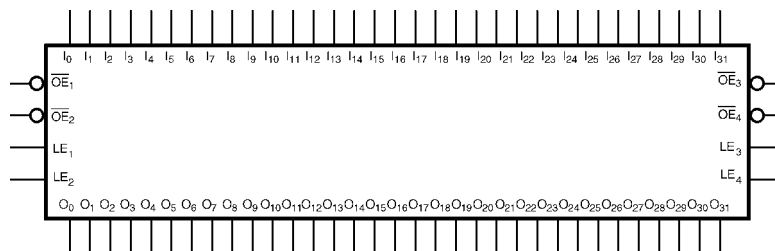
- Input and output interface capability to systems at 5V  $V_{CC}$
- Bushold data inputs eliminate the need for external pull-up resistors to hold unused inputs (74LVTH32373), also available without bushold feature (74LVT32373)
- Live insertion/extraction permitted
- Power Up/Down high impedance provides glitch-free bus loading
- Outputs source/sink -32 mA/+64 mA
- ESD performance:
  - Human-body model > 2000V
  - Machine model > 200V
  - Charged-device model > 1000V
- Packaged in plastic Fine-Pitch Ball Grid Array (FBGA) (Preliminary)

### Ordering Code:

Order Number	Package Number	Package Description
74LVT32373GX (Note 1)	BGA96A (Preliminary)	96-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide [TAPE and REEL]
74LVTH32373GX (Note 1)	BGA96A (Preliminary)	96-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide [TAPE and REEL]

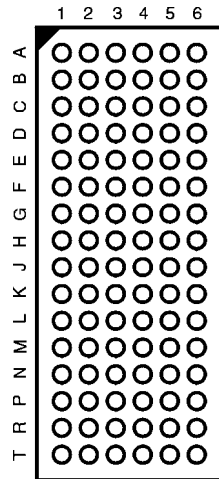
Note 1: BGA package available in Tape and Reel only.

### Logic Symbol



74LVT32373 • 74LVTH32373 Low Voltage 32-Bit Transparent Latch with 3-STATE Outputs (Preliminary)

Connection Diagram



(Top Thru View)

Pin Descriptions

Pin Names	Description
$\overline{OE}_n$	Output Enable Input (Active LOW)
$LE_n$	Latch Enable Input
$I_0-I_{31}$	Inputs
$O_0-O_{31}$	3-STATE Outputs

FBGA Pin Assignments

	1	2	3	4	5	6
<b>A</b>	$O_1$	$O_0$	$\overline{OE}_1$	$LE_1$	$I_0$	$I_1$
<b>B</b>	$O_3$	$O_2$	GND	GND	$I_2$	$I_3$
<b>C</b>	$O_5$	$O_4$	$V_{CC1}$	$V_{CC1}$	$I_4$	$I_5$
<b>D</b>	$O_7$	$O_6$	GND	GND	$I_6$	$I_7$
<b>E</b>	$O_9$	$O_8$	GND	GND	$I_8$	$I_9$
<b>F</b>	$O_{11}$	$O_{10}$	$V_{CC1}$	$V_{CC1}$	$I_{10}$	$I_{11}$
<b>G</b>	$O_{13}$	$O_{12}$	GND	GND	$I_{12}$	$I_{13}$
<b>H</b>	$O_{14}$	$O_{15}$	$\overline{OE}_2$	$LE_2$	$I_{15}$	$I_{14}$
<b>J</b>	$O_{17}$	$O_{16}$	$\overline{OE}_3$	$LE_3$	$I_{16}$	$I_{17}$
<b>K</b>	$O_{19}$	$O_{18}$	GND	GND	$I_{18}$	$I_{19}$
<b>L</b>	$O_{21}$	$O_{20}$	$V_{CC2}$	$V_{CC2}$	$I_{20}$	$I_{21}$
<b>M</b>	$O_{23}$	$O_{22}$	GND	GND	$I_{22}$	$I_{23}$
<b>N</b>	$O_{25}$	$O_{24}$	GND	GND	$I_{24}$	$I_{25}$
<b>P</b>	$O_{27}$	$O_{26}$	$V_{CC2}$	$V_{CC2}$	$I_{26}$	$I_{27}$
<b>R</b>	$O_{29}$	$O_{28}$	GND	GND	$I_{28}$	$I_{29}$
<b>T</b>	$O_{30}$	$O_{31}$	$\overline{OE}_4$	$LE_4$	$I_{31}$	$I_{30}$

Truth Table

Inputs			Outputs
$CP_1$	$\overline{OE}_1$	$I_0-I_7$	$O_0-O_7$
X	H	X	Z
H	L	L	L
H	L	H	H
L	L	X	$O_0$

Inputs			Outputs
$CP_3$	$\overline{OE}_3$	$I_{16}-I_{23}$	$O_{16}-O_{23}$
X	H	X	Z
H	L	L	L
H	L	H	H
L	L	X	$O_0$

Inputs			Outputs
$CP_2$	$\overline{OE}_2$	$I_8-I_{15}$	$O_8-O_{15}$
X	H	X	Z
H	L	L	L
H	L	H	H
L	L	X	$O_0$

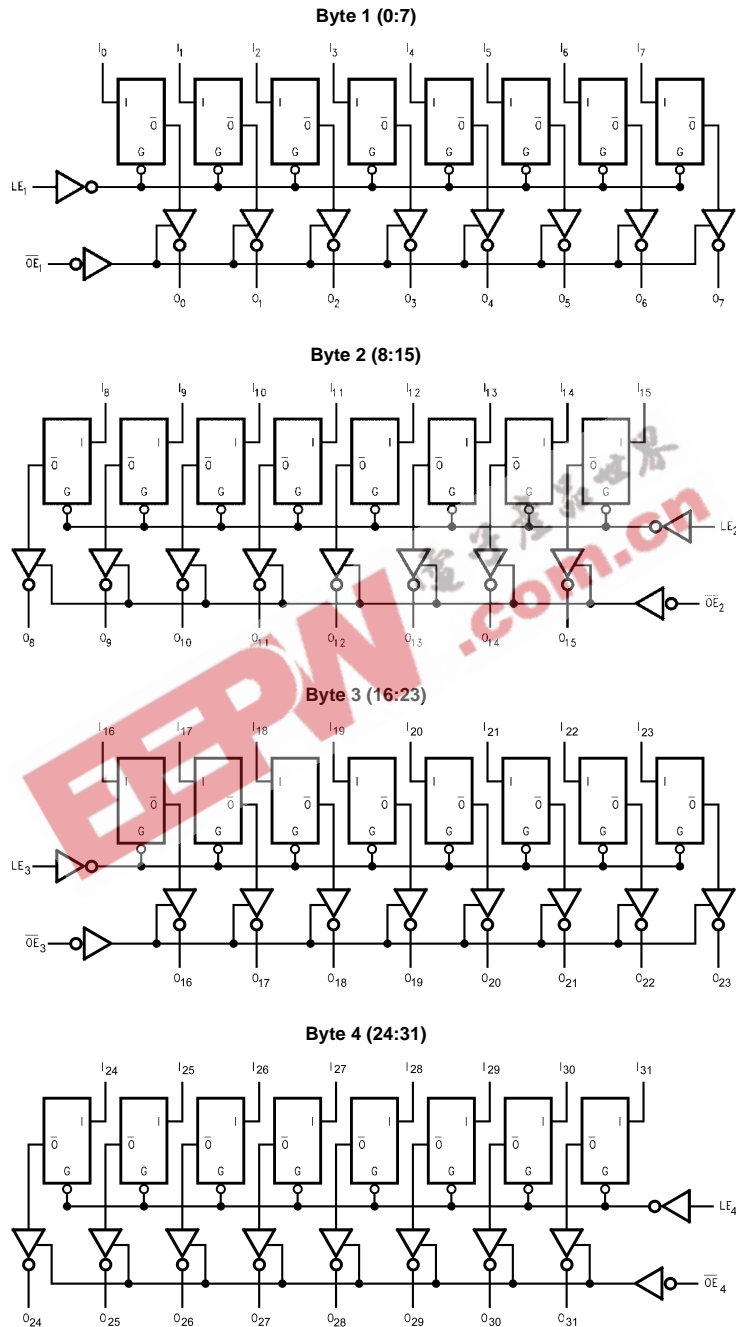
Inputs			Outputs
$CP_4$	$\overline{OE}_4$	$I_{24}-I_{31}$	$O_{24}-O_{31}$
X	H	X	Z
H	L	L	L
H	L	H	H
L	L	X	$O_0$

H = HIGH Voltage Level L = LOW Voltage Level X = Immaterial Z = HIGH Impedance  $O_0$  = Previous  $O_0$  prior to HIGH-to-LOW transition of  $LE$

Functional Description

The LVT32373 and LVTH32373 contain thirty-two D-type latches with 3-STATE standard outputs. The device is byte controlled with each byte functioning identically, but independent of the other. Control pins can be shorted together to obtain full 32-bit operation. The following description applies to each byte. When the Latch Enable ( $LE_n$ ) input is HIGH, data on the  $D_n$  enters the latches. In this condition the latches are transparent, i.e., a latch output will change states each time its D input changes. When  $LE_n$  is LOW, the latches store information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of  $LE_n$ . The 3-STATE standard outputs are controlled by the Output Enable ( $\overline{OE}_n$ ) input. When  $\overline{OE}_n$  is LOW, the standard outputs are in the 2-state mode. When  $\overline{OE}_n$  is HIGH, the standard outputs are in the high impedance mode but this does not interfere with entering new data into the latches.

Logic Diagrams



$V_{CC1}$  is associated with Bytes 1 and 2.

$V_{CC2}$  is associated with Bytes 3 and 4.

**Note:** Please note that these diagrams are provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 2)				
Symbol	Parameter	Value	Conditions	Units
V <sub>CC</sub>	Supply Voltage	-0.5 to +4.6		V
V <sub>I</sub>	DC Input Voltage	-0.5 to +7.0		V
V <sub>O</sub>	DC Output Voltage	-0.5 to +7.0	Output in 3-STATE	V
		-0.5 to +7.0	Output in HIGH or LOW State (Note 3)	
I <sub>IK</sub>	DC Input Diode Current	-50	V <sub>I</sub> < GND	mA
I <sub>OK</sub>	DC Output Diode Current	-50	V <sub>O</sub> < GND	mA
I <sub>O</sub>	DC Output Current	64	V <sub>O</sub> > V <sub>CC</sub> Output at HIGH State	mA
		128	V <sub>O</sub> > V <sub>CC</sub> Output at LOW State	
I <sub>CC</sub>	DC Supply Current per Supply Pin	±64		mA
I <sub>GND</sub>	DC Ground Current per Ground Pin	±128		mA
T <sub>STG</sub>	Storage Temperature	-65 to +150		°C

Recommended Operating Conditions				
Symbol	Parameter	Min	Max	Units
V <sub>CC</sub>	Supply Voltage	2.7	3.6	V
V <sub>I</sub>	Input Voltage	0	5.5	V
I <sub>OH</sub>	HIGH Level Output Current		-32	mA
I <sub>OL</sub>	LOW Level Output Current		64	mA
T <sub>A</sub>	Free-Air Operating Temperature	-40	85	°C
Δt/ΔV	Input Edge Rate, V <sub>IN</sub> = 0.8V–2.0V, V <sub>CC</sub> = 3.0V	0	10	ns/V

**Note 2:** Absolute Maximum continuous ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute maximum rated conditions is not implied.

**Note 3:** I<sub>O</sub> Absolute Maximum Rating must be observed.

DC Electrical Characteristics							
Symbol	Parameter	V <sub>CC</sub> (V)	T <sub>A</sub> = -40°C to +85°C		Units	Conditions	
			Min	Max			
V <sub>IK</sub>	Input Clamp Diode Voltage	2.7		-1.2	V	I <sub>I</sub> = -18 mA	
V <sub>IH</sub>	Input HIGH Voltage	2.7–3.6	2.0		V	V <sub>O</sub> ≤ 0.1V or	
V <sub>IL</sub>	Input LOW Voltage	2.7–3.6		0.8	V	V <sub>O</sub> ≥ V <sub>CC</sub> - 0.1V	
V <sub>OH</sub>	Output HIGH Voltage	2.7–3.6	V <sub>CC</sub> - 0.2		V	I <sub>OH</sub> = -100 μA	
		2.7	2.4			I <sub>OH</sub> = -8 mA	
		3.0	2.0			I <sub>OH</sub> = -32 mA	
V <sub>OL</sub>	Output LOW Voltage	2.7		0.2	V	I <sub>OL</sub> = 100 μA	
		2.7		0.5		I <sub>OL</sub> = 24 mA	
		3.0		0.4		I <sub>OL</sub> = 16 mA	
		3.0		0.5		I <sub>OL</sub> = 32 mA	
		3.0		0.55		I <sub>OL</sub> = 64 mA	
I <sub>I(HOLD)</sub> (Note 4)	Bushold Input Minimum Drive	3.0	75		μA	V <sub>I</sub> = 0.8V	
			-75			V <sub>I</sub> = 2.0V	
I <sub>I(OD)</sub> (Note 4)	Bushold Input Over-Drive Current to Change State	3.0	500		μA	(Note 5)	
			-500			(Note 6)	
I <sub>I</sub>	Input Current	3.6		10	μA	V <sub>I</sub> = 5.5V	
		Control Pins	3.6			±1	V <sub>I</sub> = 0V or V <sub>CC</sub>
			Data Pins	3.6			-5
				1		V <sub>I</sub> = V <sub>CC</sub>	
I <sub>OFF</sub>	Power Off Leakage Current	0		±100	μA	0V ≤ V <sub>I</sub> or V <sub>O</sub> ≤ 5.5V	
I <sub>PU/PD</sub>	Power up/down 3-STATE Output Current	0–1.5V		±100	μA	V <sub>O</sub> = 0.5V to 3.0V V <sub>I</sub> = GND or V <sub>CC</sub>	
I <sub>OZL</sub>	3-STATE Output Leakage Current	3.6		-5	μA	V <sub>O</sub> = 0.5V	
I <sub>OZH</sub>	3-STATE Output Leakage Current	3.6		5	μA	V <sub>O</sub> = 3.0V	
I <sub>OZH+</sub>	3-STATE Output Leakage Current	3.6		10	μA	V <sub>CC</sub> < V <sub>O</sub> ≤ 5.5V	

DC Electrical Characteristics (Continued)							
Symbol	Parameter	V <sub>CC</sub> (V)	T <sub>A</sub> = -40°C to +85°C		Units	Conditions	
			Min	Max			
I <sub>CCH</sub>	Power Supply Current (V <sub>CC1</sub> or V <sub>CC2</sub> )	3.6		0.19	mA	Outputs HIGH	
I <sub>CCL</sub>	Power Supply Current (V <sub>CC1</sub> or V <sub>CC2</sub> )	3.6		5	mA	Outputs LOW	
I <sub>CCZ</sub>	Power Supply Current (V <sub>CC1</sub> or V <sub>CC2</sub> )	3.6		0.19	mA	Outputs Disabled	
I <sub>CCZ+</sub>	Power Supply Current (V <sub>CC1</sub> or V <sub>CC2</sub> )	3.6		0.19	mA	V <sub>CC</sub> ≤ V <sub>O</sub> ≤ 5.5V, Outputs Disabled	
ΔI <sub>CC</sub>	Increase in Power Supply Current (V <sub>CC1</sub> or V <sub>CC2</sub> ) (Note 7)	3.6		0.2	mA	One Input at V <sub>CC</sub> - 0.6V Other Inputs at V <sub>CC</sub> or GND	
<p><b>Note 4:</b> Applies to bushold versions only (74LVTH32373).</p> <p><b>Note 5:</b> An external driver must source at least the specified current to switch from LOW-to-HIGH.</p> <p><b>Note 6:</b> An external driver must sink at least the specified current to switch from HIGH-to-LOW.</p> <p><b>Note 7:</b> This is the increase in supply current for each input that is at the specified voltage level rather than V<sub>CC</sub> or GND.</p>							
Dynamic Switching Characteristics (Note 8)							
Symbol	Parameter	V <sub>CC</sub> (V)	T <sub>A</sub> = 25°C			Units	Conditions C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500Ω
			Min	Typ	Max		
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>	3.3		0.8	V	(Note 9)	
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>	3.3		-0.8	V	(Note 9)	
<p><b>Note 8:</b> Characterized in SSOP package. Guaranteed parameter, but not tested.</p> <p><b>Note 9:</b> Max number of outputs defined as (n). n-1 data inputs are driven 0V to 3V. Output under test held LOW.</p>							
AC Electrical Characteristics							
Symbol	Parameter	T <sub>A</sub> = -40°C to +85°C, C <sub>L</sub> = 50pF, R <sub>L</sub> = 500Ω				Units	
		V <sub>CC</sub> = 3.3V ± 0.3V		V <sub>CC</sub> = 2.7V			
		Min	Max	Min	Max		
t <sub>PHL</sub>	Propagation Delay	1.5	3.9	1.5	4.3	ns	
t <sub>PLH</sub>	D <sub>n</sub> to O <sub>n</sub>	1.5	3.8	1.5	4.2		
t <sub>PHL</sub>	Propagation Delay	1.9	4.2	1.9	4.4	ns	
t <sub>PLH</sub>	LE to O <sub>n</sub>	1.6	4.3	1.6	4.8		
t <sub>PZL</sub>	Output Enable Time	1.3	4.3	1.3	4.9	ns	
t <sub>PZH</sub>		1.0	4.3	1.0	5.1		
t <sub>PLZ</sub>	Output Disable Time	1.5	4.7	1.5	4.8	ns	
t <sub>PHZ</sub>		2.0	5.0	2.0	5.4		
t <sub>S</sub>	Setup Time, D <sub>n</sub> to LE	1.0		0.8		ns	
t <sub>H</sub>	Hold Time, D <sub>n</sub> to LE	1.0		1.1		ns	
t <sub>W</sub>	LE Pulse Width	3.0		3.0		ns	
Capacitance (Note 10)							
Symbol	Parameter	Conditions		Typical	Units		
C <sub>IN</sub>	Input Capacitance	V <sub>CC</sub> = Open, V <sub>I</sub> = 0V or V <sub>CC</sub>		4	pF		
C <sub>OUT</sub>	Output Capacitance	V <sub>CC</sub> = 3.0V, V <sub>O</sub> = 0V or V <sub>CC</sub>		8	pF		
<p><b>Note 10:</b> Capacitance is measured at frequency f = 1 MHz, per MIL-STD-883, Method 3012.</p>							

**Physical Dimensions** inches (millimeters) unless otherwise noted

**Top View**

**Bottom View**

**SEATING PLANE**

**NOTES:**

- A. THIS PACKAGE CONFORMS TO JEDEC M0-205
- B. ALL DIMENSIONS IN MILLIMETERS
- C. LAND PATTERN RECOMMENDATION: NSMD (Non Solder Mask Defined)  
.35MM DIA PADS WITH A SOLDERMASK OPENING OF .45MM CONCENTRIC TO PADS
- D. DRAWING CONFORMS TO ASME Y14.5M-1994

**BGA96ArevE**

**96-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC M0-205, 5.5mm Wide  
Package Number BGA96A  
Preliminary**

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